# ANNING KELVIN PROBE SYSTEM

The SKP5050 is a comprehensive scanning Kelvin Probe solution. As a natural upgrade from the KP020, it comes with everything needed to produce reliable, repeatable measurements, due to the unique features provided by the 'Baikie System'. System set-up is a dream, thanks to the high-resolution 3-axis stages, and users can quickly perform 50x50mm scans. A high performance faraday and light enclosure comes with the SKP5050 as standard, shielding the SKP5050 from unwanted electromagnetic interference and providing the perfect platform for our SPV020 and SPS030 systems.

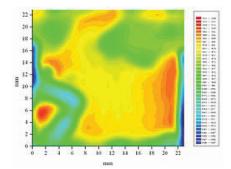
Tailor the system to your exact needs with the addition of larger sample holders or heaters, or consider the RHC020 to monitor work function changes under varying environmental conditions.

The SKP5050 has been our benchmark system for a number of years and has been applied successfully in research areas such as: organic thin-films, corrosion, semiconductors, roll to roll solar cells, OLED's, tribilogy. For advice on applications in your area call the Kelvin Probe Specialists and enjoy the benefits of 30 years of Kelvin Probe experience.

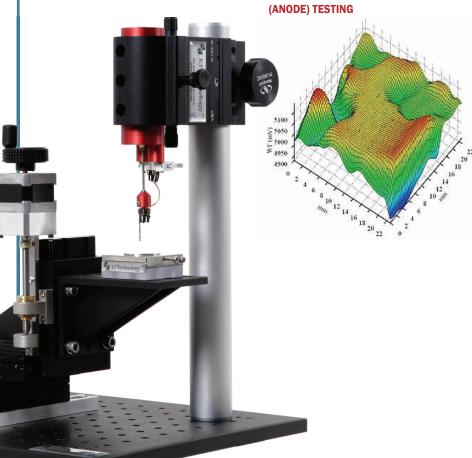
The Kelvin Probe is a non-contact, non-destructive vibrating capacitor device used to measure the work function (wf) of conducting materials or surface potential of semiconductor or insulating surfaces. The wf of a surface is typically defi ned by the topmost 1-3 layers of atoms or molecules, so the Kelvin Probe is one of the most sensitive surface analysis techniques available. KP Technology Systems off er very high wf resolution of 1-3 meV, currently the highest achieved by any commercial device.

I have been working the scanning Kelvin Probe and I have become quite comfortable with it. It is an excellent device and exquisitely sensitive.

Prof. Andrew Ahn Harvard University, USA



NON HOMOGENOUS COVERAGE POLYMER



# SCANNING KELVIN PROBE SYSTEM SKP5050

#### THE BAIKIE SYSTEM

All KP Technology Systems are based upon unique features developed by Professor Iain Baikie. These features are unsurpassed by any other company.

- ◆ Highest work function/ surface potential resolution of 1 - 3 meV (standard with 2mm tip).
- Voice Coil driver provides very high rejection of driver talkover noise compared with piezoelectric systems.
- ◆ Off null signal detection system for vastly improved resolution - Our Signal-to-Noise (S/N) features remain unsurpassed in the field.
- ◆ Height regulation feature to control the tip to sample spacing during measurements and scans which allow for stable, reliable and repeatable results.
- Full digital control of all Kelvin Probe parameters.



**KP**Technology



#### SYSTEM SPECIFICATIONS

- ◆ 2mm and 50 micron tips standard
- ◆ Work Function resolution of 1-3meV (2mm tip), 5-10meV (50 micron with optical table support)
- ◆ 50mm x 50 mm maximum scan area
- ◆ 318 nanometer position resolution
- ◆ Tracking System with automatic motorized control of tip to sample spacing
- Additional Manual Height Control (25.4mm KP translation for coarse positioning)
- ♦ Off-null detection system with parasitic capacity rejection

### **SOFTWARE FEATURES**

- ◆ Digital Control of all Kelvin Probe parameters
- ◆ Simple set-up procedure for signal optimisation
- ◆ Fast measurement mode for tracking real time work function changes (1000 work function points / min at ~20meV resolution)
- ◆ Variable scan size and real-time 3D charting of sample work function
- ◆ Export of data to scientific analysis software

### SYSTEM PACKAGE DESCRIPTION

- ◆ Kelvin Probe Head Unit with Integrated Tip Amplifier
- ◆ 2mm and 50 micron tip
- ♦ High Performance 450x450x500 Faraday Screen and Light Enclosure
- ◆ 450x450x12.7mm optical base breadboard
- ◆ 3-axis motorised scanning stage
- ◆ Optical Camera with 9" TFT Monitor to monitor tip-sample position
- ◆ Sample Holder
- Gold Aluminium Reference Sample
- Digital Control Unit
- ◆ Dell PC with monitor
- ◆ Pre-installed KP software and Data Acquisition system
- Spare Tip Amplifier
- ◆ Autosensing Power Supply Unit
- ◆ Digital Oscilloscope for real-time signal display
- ◆ 24 Month Warranty

## **ADDITIONAL OPTIONS**

- ◆ Inline Tip Holder for 50 micron to 20mm diameter tips
- ◆ Sample Holder for Larger Sample such as Silicon Wafers
- ◆ Sample Heater
- ◆ Upgrade to RHC system



